Display Elektronik GmbH

DATA SHEET

OLED-MODULE

DEP 128064D-Y 1,28" - OLED

Product Specification

Ver.: 0

1. Revision History

VERSION	DATE	REVISED PAGE NO.	Note
0	25.02.2016		First Release

Contents

- 1. General Specification
- 2. Interface Pin Function
- 3. Counter Drawing & Block Diagram
- 4. Absolute Maximum Ratings
- 5. Electrical Characteristics
- 6. Optical Characteristics
- 7. OLED Lifetime
- 8. Reliability
- 9. Inspection specification
- 10. Precautions in use of OLED Modules

1. General Specification

The Features is described as follow:

■ Module Dimension: 34.50 x 23.00 x 1.65 mm

Active Area: 29.42 x 14.20 mm

■ Dot Matrix: 128 x 64

Pixel Size: 0.205 x 0.197 mm
 Pixel Pitch: 0.230 x 0.222 mm
 Display Mode: Passive Matrix

■ Duty: 1/64 Duty

■ Display Color: Yellow

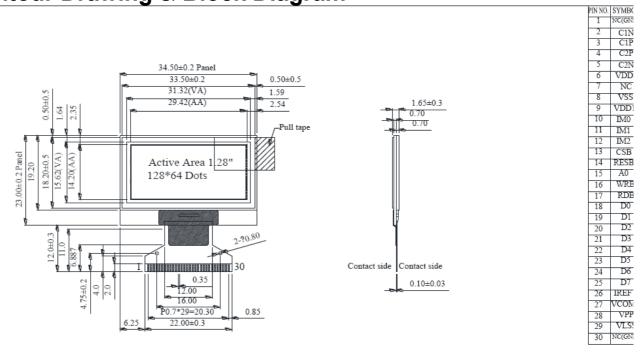
■ IC: SH1106G

2. Interface Pin Function

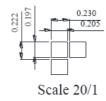
No.	Symbol	Function						
1	NC(GND)	No conne	lo connection					
2	C1N		onnect to charge pump capacitor.					
3	C1P	These pirexternally	ese pins are not used and should be disconnected when Vpp is supplied					
4	C2P			mp capacitor				
5	C2N	externally	/.				Vpp is suppli	ied
6	VDD2					for charge pu supplied exte		
7	NC	No conne	ection					
8	VSS	Ground.						
9	VDD1		ipply input: 1					
10	IM0	These ar	e the MPU ir	nterface mode	e select pads	3.		
-			8080	I ² C	6800	4-wire SPI	3-wire SPI	
11	IM1	IM0	0	0	0	0	1	
		IM1	1	1	0	0	0	
12	IM2	IM2	1	0	1	0	0	
13	CSB	becomes	active,	elect input. W		'L", then the	chip select	•
14	RESB	initialized	. The reset			et to "L", the	settings are	
15	A0	This is th are data command A0 = "H": A0 = "L":	Peration is performed by the RES signal level. This is the Data/Command control pad that determines whether the data bits are data or a command. A0 = "H": the inputs at D0 to D7 are treated as display data. A0 = "L": the inputs at D0 to D7 are transferred to the command registers. A1 I I I I I I I I I I I I I I I I I I I					
16	WRB	This is a When co the 8080 signal. The signal when co input term When R/	MPU interfaction and the most of the median MPU WR the signals on the most of the median median median and the median med	n 8080 MPU the data bus 6800 Series	s are latched	at the rising	pad connects edge of the \ ite control sig	WR

17	RDB	This is a MPU interface input pad. When connected to an 8080 series MPU, it is active LOW. This pad is connected to the RD signal of the 8080 series MPU, and the data bus is in an output status when this signal is "L". When connected to a 6800 series MPU, this is active HIGH. This is used as an enable clock input of the 6800 series MPU. When RD = "H": Enable. When RD = "L": Disable.
18	D0	This is an 8-bit bi-directional data bus that connects to an 8-bit or 16-bit
19	D1	standard MPU data bus.
20	D2	When the serial interface is selected, then D0 serves as the serial clock input
21	D3	pad (SCL) and D1
22	D4	serves as the serial data input pad (SI). At this time, D2 to D7 are set to high
23	D5	impedance.
24	D6	When the I2C interface is selected, then D0 serves as the serial clock input pad (SCL) and D1
25	D7	serves as the serial data input pad (SDAI). At this time, D2 to D7 are set to high impedance.
26	IREF	This is a segment current reference pad. A resistor should be connected between this pad and VSS. Set the current at 12.5mA.
27	VCOMH	This is a pad for the voltage output high level for common signals. A capacitor should be connected between this pad and VSS.
28	VPP	OLED panel power supply. Generated by internal charge pump. Connect to capacitor. It could be supplied externally.
29	VLSS	This is a segment voltage reference pad. This pad should be connected to VSS externally.
30	NC(GND)	No connection

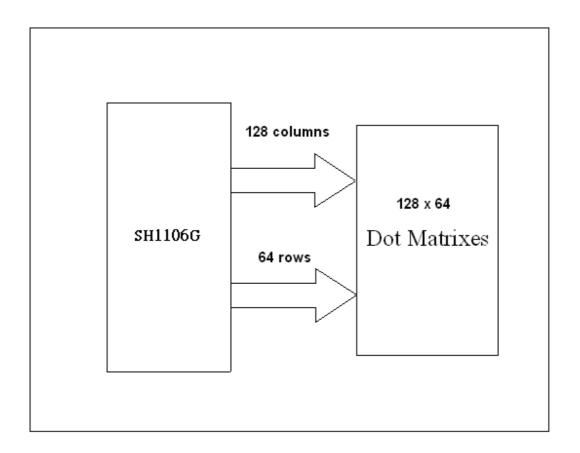
3. Contour Drawing & Block Diagram



The non-specified tolerance of dimension is ± 0.3 mm.



<u>DEP 128064D-Y</u> FUNCTION BLOCK DIAGRAM



^{*}For more information, please refer to Application Note provided by DISPLAY.

4. Absolute Maximum Ratings

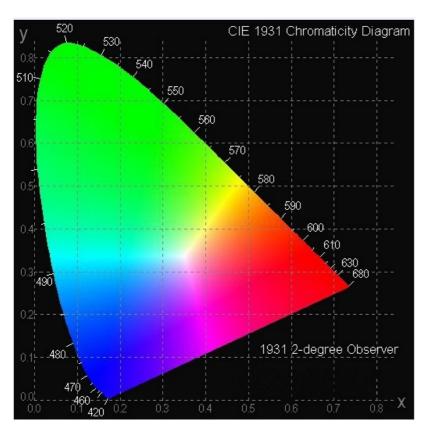
Parameter	Symbol	Min	Max	Unit
Supply Voltage for Logic	VDD1	-0.3	3.6	V
Power supply for charge pump circuit	VDD2	-0.3	4.8	V
Supply Voltage for Display	VPP	-0.3	14.5	V
Operating Temperature	TOP	-40	+80	°C
Storage Temperature	TSTG	-40	+80	°C

5. Electrical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
Supply Voltage for Logic	VDD	_	2.8	3.0	3.3	V
Supply Voltage for Display	VCC	_	7	7.25	7.5	V
High Level Input	VIH	_	0.8VDD	_	VDD	V
Low Level Input	VIL	_	VSS	_	0.2VDD	V
High Level Output	VOH	_	0.8VDD	_	VDD	V
Low Level Input	VOL	_	VSS	_	0.2VDD	V
50% Check Board operating C	urrent	VCC =7.25V	5	6	7	mA

6. Optical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
View Angle	(V)θ	_	160	_	_	deg
View / tilgie	(Η)φ	_	160	_	_	deg
Contrast Ratio	CR	Dark	2000:1	_	_	_
Response Time	T rise	_	_	10	_	μs
Treopense Time	T fall	_	_	10	_	μs
Display with 50% check	Board Brightnes	S	100	120	_	cd/m2
CIEx(Yellow)	x,y(CIE1931)	0.45	0.47	0.49	_	
CIEy(Yellow)	x,y(CIE1931)	0.48	0.50	0.52	_	



7. OLED Lifetime

ITEM	Conditions	Min	Тур	Remark
Operating Life Time	Ta=25°C / Initial 50% check board brightness Typical Value	50,000 Hrs	-	Note

Notes:

- 1. Life time is defined the amount of time when the luminance has decayed to <50% of the initial value.
- 2. This analysis method uses life data obtained under accelerated conditions to extrapolate an estimated probability density function (*pdf*) for the product under normal use conditions.
- 3. Screen saving mode will extend OLED lifetime.

8. Reliability

High Endurance test applying the high storage temperature for a long time. Endurance test applying the low storage temperature for a long time. Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. Endurance test applying the electric stress under low temperature for a long time. Endurance test applying the electric stress under low temperature for a long time. Endurance test applying the high temperature and high humidity storage for a long time. Endurance test applying the low and high temperature cycle. 40	Environmenta	l Test		
Temperature storage storage temperature for a long time. Endurance test applying the low storage temperature for a long time. Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. Endurance test applying the electric stress under low temperature for a long time. Endurance test applying the high temperature and high humidity storage for a long time. Endurance test applying the high temperature and high humidity storage for a long time. Endurance test applying the low and high temperature cycle. Endurance test applying the low and high temperature cycle. Temperature Cycle Endurance test applying the vibration durin transportation and using. Endurance test applying the vibration during transportation and using. Constructional and mechanical endurance test applying the shock during transportation. Endurance test applying the shock during transportation by air. Endurance test applying the atmospheric pressure during transportation by air. Endurance test applying the atmospheric pressure during transportation by air. Endurance test applying the electric stress (Voltage & Current) and	Test Item	Content of Test	Test Condition	Applicable Standard
temperature between temperature for a long time. High Temperature Operation Low Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time. Low Endurance test applying the electric stress under low temperature for a long time. High Temperature/ Department of the properature of the properature of a long time. Endurance test applying the high temperature and high humidity storage for a long time. Endurance test applying the low and high temperature cycle. Temperature Cycle Endurance test applying the low and high temperature cycle. Temperature Cycle Endurance test applying the vibration during transportation and using. Constructional and mechanical endurance test applying the shock during transportation. Endurance test applying the shock during transportation by air. Endurance test applying the atmospheric pressure test applying the electric stress under low temperature of a long 240hrs 100	High Temperature storage			
tremperature Operation Low Endurance test applying the electric stress under low temperature for a long 240hrs Endurance test applying the high temperature and high humidity storage for a long time. Endurance test applying the low and high temperature cycle. -40 25 80	Temperature			
Temperature Operation time. High Temperature/ Humidity Storage Endurance test applying the high temperature and high humidity storage for a long time. Endurance test applying the low and high temperature cycle. Temperature Cycle Endurance test applying the low and high temperature cycle. 40 25 80 100 cycles Temperature Cycle Temperature Cycle Temperature Cycle Temperature Cycle Temperature Cycle Cycle Endurance test applying the vibration during transportation and using. Constructional and mechanical endurance test applying the shock during transportation. Endurance test applying the shock during transportation. Endurance test applying the atmospheric pressure test applying the atmospheric pressure during transportation by air. Endurance test applying the atmospheric pressure during transportation by air. Endurance test applying the alectric VS=800V,RS=1.5kΩ Endurance test applying the electric VS=800V,RS=1.5kΩ	Temperature	stress (Voltage & Current) and the thermal stress to the element for a long		
Temperature/ Humidity Storage Endurance test applying the lings for a long time. Endurance test applying the low and high temperature cycle. -40	Temperature	stress under low temperature for a long		
Temperature Cycle Au	Temperature/ Humidity	temperature and high humidity storage		
Vibration test Endurance test applying the vibration during transportation and using. 10~22Hz→1.5mmp-p 22~500Hz→1.5G Total 0.5hr Shock test Constructional and mechanical endurance test applying the shock during transportation. 50G Half sin wave 11 ms 3 times of each direction Atmospheric pressure test Endurance test applying the atmospheric pressure during transportation by air. 115mbar 40hrs Others VS=800V,RS=1.5kΩ		high temperature cycle. -40 25 80 30min 5min 30min		
Vibration test Endurance test applying the vibration during transportation and using. 22~500Hz→1.5G Total 0.5hr Shock test Constructional and mechanical endurance test applying the shock during transportation. 50G Half sin wave 11 ms 3 times of each direction Atmospheric pressure test Endurance test applying the atmospheric pressure during transportation by air. 115mbar 40hrs Others VS=800V,RS=1.5kΩ	Mechanical Tes	st		
Shock test Constructional and mechanical endurance test applying the shock during transportation. Atmospheric pressure test Constructional and mechanical wave 11 ms 3 times of each direction Endurance test applying the atmospheric pressure during transportation by air. Others Endurance test applying the electric VS=800V,RS=1.5kΩ	Vibration test		22~500Hz→1.5G Total 0.5hr	
Atmospheric pressure during transportation by air. Others Endurance test applying the electric VS=800V,RS=1.5kΩ	Shock test	endurance test applying the shock	wave 11 ms 3 times of each	
Static Endurance test applying the electric VS=800V,RS=1.5kΩ		atmospheric pressure during		
	Others			
electricity test stress to the terminal. CS=100pF	Static electricity test	Endurance test applying the electric stress to the terminal.	CS=100pF	

^{***} Supply voltage for OLED system =Operating voltage at 25°C

Test and measurement conditions

- 1. All measurements shall not be started until the specimens attain to temperature stability. After the completion of the described reliability test, the samples were left at room temperature for 2 hrs prior to conducting the failure test at 23±5°C; 55±15% RH.
- 2. All-pixels-on is used as operation test pattern.
- 3. The degradation of Polarizer are ignored for High Temperature storage, High Temperature/ Humidity Storage, Temperature Cycle

Evaluation criteria

- 1. The function test is OK.
- 2. No observable defects.
- 3. Luminance: > 50% of initial value.
- 4. Current consumption: within ± 50% of initial value.

APPENDIX:

RESIDUE IMAGE

Because the pixels are lighted in different time, the luminance of active pixels may reduce or differ from inactive pixels. Therefore, the residue image will occur. To avoid the residue image, every pixel needs to be lighted up uniformly.

<u>DEP 128064D-Y</u>**9. Inspection specification**

NO	Item	Criterion					AQL
01	Electrical Testing	defect. 1.2 Missing char 1.3 Display malf 1.4 No function of 1.5 Current cons 1.6 OLED viewir 1.7 Mixed produ	1.2 Missing character, dot or icon. 1.3 Display malfunction.			0.65	
02	Black or white spots on OLED (display only)	three white or black 2.2 Densely spands 3mm.	ım.			2.5	
03	OLED black spots, white spots, contamina tion (non-display)	3.1 Round type following drawing Φ=(x+y)/2 X T			SIZE $\Phi \le 0.10$ $0.10 < \Phi \le 0.20$ $0.20 < \Phi \le 0.25$ $0.25 < \Phi$	Acceptable Q TY Accept no dense 2	2.5
		3.2 Line type : (A	Length L≦3.0 L≦2.5	Wid W ± 0.0		Acceptable Q TY Accept no dense 2 As round type	2.5
04	Polarizer bubbles	If bubbles are vis judge using blac specifications, no to find, must che specify direction	k spot ot easy eck in	Φ: 0.2 0.5 1.0	ze Φ ≤ 0.20 20 < Φ ≤ 0.50 50 < Φ ≤ 1.00 00 < Φ tal Q TY	Acceptable Q TY Accept no dense 3 2 0 3	2.5

NO	Item	Criterion	AQL
05	Scratches	Follow NO.3 OLED black spots, white spots, contamination	
	Scratches	Follow NO.3 OLED black spots, white spots, contamination Symbols Define: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: OLED side length L: Electrode pad length: 6.1 General glass chip: 6.1.1 Chip on panel surface and crack between panels: $z: Chip thickness y: Chip width x: Chip length Z \leq 1/2t Not over viewing area$	AQL 2.5
06	Chipped glass	Z≤1/2t Not over viewing x≤1/8a	2.5
		$Z \le 1/2t$ Not over viewing $x \le 1/8a$	11
		area	
		1/2t < z ≤ 2t Not exceed 1/3k x ≤ 1/8a	1
		⊙ If there are 2 or more chips, x is the total length of each chip.	1

NO	Item	Criterion	AQL			
NO 06	Item	Criterion Symbols: x: Chip length				
	crack	y X X X X Y X Y X Y Y Y Y Y Y Y Y Y Y Y				
		thickness				
		$y \le L$ $x \le 1/8a$ $0 < z \le t$				
		⊙ If the chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal				
		specifications.				
		⊙ If the product will be heat sealed by the customer, the alignment				
		mark not be damaged. 6.2.3 Substrate protuberance and internal crack.				
		y: width x: length				
		$y \le 1/3L$ $x \le a$				
		v V				

NO	Item	Criterion	AQL
07	Cracked glass	The OLED with extensive crack is not acceptable.	2.5
08	Backlight elements	 8.1 Illumination source flickers when lit. 8.2 Spots or scratched that appear when lit must be judged. Using OLED spot, lines and contamination standards. 8.3 Backlight doesn't light or color wrong. 	0.65 2.5 0.65
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications.	2.5 0.65
10	PCB、COB	 10.1 COB seal may not have pinholes larger than 0.2mm or contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places. 10.5 No oxidation or contamination PCB terminals. 10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts. 10.7 The jumper on the PCB should conform to the product characteristic chart. 10.8 If solder gets on bezel tab pads, OLED pad, zebra pad or screw hold pad, make sure it is smoothed down. 	2.5 2.5 0.65 2.5 0.65 0.65 2.5
11	Soldering	 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 11.4 No short circuits in components on PCB. 	2.5 2.5 2.5 0.65

NO	Item	Criterion	AQL
12	General appearance	 12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP. 12.2 No cracks on interface pin (OLB) of TCP. 12.3 No contamination, solder residue or solder balls on product. 12.4 The IC on the TCP may not be damaged, circuits. 12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it cause the interface pin to sever. 12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color. 12.7 Sealant on top of the ITO circuit has not hardened. 12.8 Pin type must match type in specification sheet. 12.9 OLED pin loose or missing pins. 12.10 Product packaging must the same as specified on packaging specification sheet. 12.11 Product dimension and structure must conform to product specification sheet. 	2.5 0.65 2.5 2.5 2.5 2.5 2.5 0.65 0.65 0.65

Check Item	Classification Criteria	
No Display	Major	
Missing Line	Major	
Pixel Short	Major	
Darker Short	Major	
Wrong Display	Major	
Un-uniform B/A x 100% < 70% A/C x 100% < 70%	Major	A Normal B Dark Pixel C Light Pixel

10. Precautions in use of OLED Modules

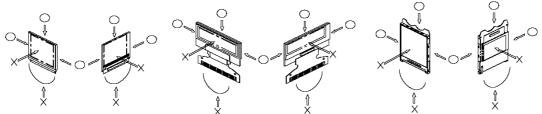
- (1) Avoid applying excessive shocks to module or making any alterations or modifications to it.
- (2) Don't make extra holes on the printed circuit board, modify its shape or change the components of OLED display module.
- (3) Don't disassemble the OLED display module.
- (4) Don't operate it above the absolute maximum rating.
- (5) Don't drop, bend or twist OLED display module.
- (6) Soldering: only to the I/O terminals.
- (7) Storage: please storage in anti-static electricity container and clean environment.
- (8) It's pretty common to use "Screen Saver" to extend the lifetime and Don't use fix information for long time in real application.
- (9) Don't use fixed information in OLED panel for long time, that will extend "screen burn" effect time..
- (10) DISPLAY has the right to change the passive components, including R2and R3 adjust resistors. (Resistors, capacitors and other passive components will have different appearance and color caused by the different supplier.)
- (11) DISPLAY has the right to change the PCB Rev. (In order to satisfy the supplying stability, management optimization and the best product performance...etc, under the premise of not affecting the electrical characteristics and external dimensions, DISPLAY has the right to modify the version.)

10.1 Handling Precautions

- (1) Since the display panel is being made of glass, do not apply mechanical impacts such us dropping from a high position.
- (2) If the display panel is broken by some accident and the internal organic substance leaks out, be careful not to inhale nor lick the organic substance.
- (3) If pressure is applied to the display surface or its neighborhood of the OLED display module, the cell structure may be damaged and be careful not to apply pressure to these sections
- (4) The polarizer covering the surface of the OLED display module is soft and easily scratched. Please be careful when handling the OLED display module.
- (5) When the surface of the polarizer of the OLED display module has soil, clean the surface. It takes advantage of by using following adhesion tape.
- * Scotch Mending Tape No. 810 or an equivalent

Never try to breathe upon the soiled surface nor wipe the surface using cloth containing solvent Also, pay attention that the following liquid and solvent may spoil the polarizer:

- * Water
- * Ketone
- * Aromatic Solvents
- (6) Hold OLED display module very carefully when placing OLED display module into the System housing. Do not apply excessive stress or pressure to OLED display module. And, do not over bend the film with electrode pattern layouts. These stresses will influence the display performance. Also, secure sufficient rigidity for the outer cases.



- (7) Do not apply stress to the LSI chips and the surrounding molded sections.
- (8) Do not disassemble nor modify the OLED display module.
- (9) Do not apply input signals while the logic power is off.
- (10) Pay sufficient attention to the working environments when handing OLED display modules to prevent occurrence of element breakage accidents by static electricity.
- * Be sure to make human body grounding when handling OLED display modules.
- * Be sure to ground tools to use or assembly such as soldering irons.
- * To suppress generation of static electricity, avoid carrying out assembly work under dry environments.
- * Protective film is being applied to the surface of the display panel of the OLED display module. Be careful since static electricity may be generated when exfoliating the protective film.
- (11) Protection film is being applied to the surface of the display panel and removes the protection film before assembling it. At this time, if the OLED display module has been stored surface of the display panel after removed of the film. In such case, remove the residue material by the method introduced in the above Section 5.
- (12) If electric current is applied when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful to avoid the above.

10.2 Storage Precautions

- (1) When storing OLED display modules, put them in static electricity preventive bags avoiding exposure to direct sun light nor to lights of fluorescent lamps. And, also, avoiding high temperature and high humidity environment or low temperature (less than 0°C) environments. (We recommend you to store these modules in the packaged state when they were shipped from DISPLAY. At that time, be careful not to let water drops adhere to the packages or bags nor let dewing occur with them.
- (2) If electric current is applied when water drops are adhering to the surface of the OLED display module, when the OLED display module is being dewed or when it is placed under high humidity environments, the electrodes may be corroded and be careful about the above.

10.3 Designing Precautions

- (1) The absolute maximum ratings are the ratings which cannot be exceeded for OLED display module, and if these values are exceeded, panel damage may be happen.
- (2) To prevent occurrence of malfunctioning by noise, pay attention to satisfy the VIL and VIH specifications and, at the same time, to make the signal line cable as short as possible.
- (3) We recommend you to install excess current preventive unit (fuses, etc.) to the power circuit (VDD). (Recommend value: 0.5A)
- (4) Pay sufficient attention to avoid occurrence of mutual noise interference with the neighboring devices.
- (5) As for EMI, take necessary measures on the equipment side basically.
- (6) When fastening the OLED display module, fasten the external plastic housing section.
- (7) If power supply to the OLED display module is forcibly shut down by such errors as taking out the main battery while the OLED display panel is in operation, we cannot guarantee the quality of this OLED display module. Connection (contact) to any other potential than the above may lead to rupture of the IC.